



**CTL0502NS-R3**

## **N-Channel Enhancement MOSFET**

### **Features**

- Drain-Source Breakdown Voltage  $V_{DSS}$  20 V
- Drain-Source On-Resistance  
 $R_{DS(ON)}$  21mΩ, at  $V_{GS}$ = 4.5V,  $I_D$ = 5.0A  
 $R_{DS(ON)}$  24mΩ, at  $V_{GS}$ = 2.5V,  $I_D$ = 3.5A  
 $R_{DS(ON)}$  31mΩ, at  $V_{GS}$ = 1.8V,  $I_D$ = 2.8A
- Continuous Drain Current at  $T_A=25^\circ\text{C}$ ,  $I_D$  = 5.0A
- Advanced high cell density Trench Technology
- RoHS Compliance & Halogen Free

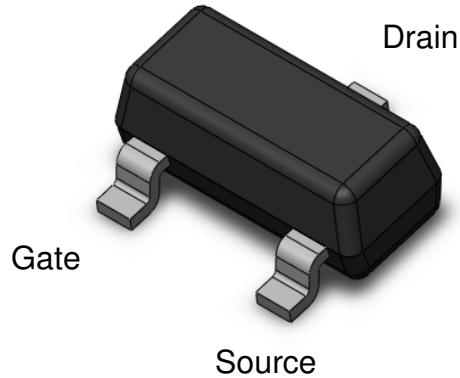
### **Description**

The CTL0502NS-R3 uses high performance Trench Technology to provide excellent  $R_{DS(ON)}$  and low gate charge which is suitable for most of the synchronous buck converter applications.

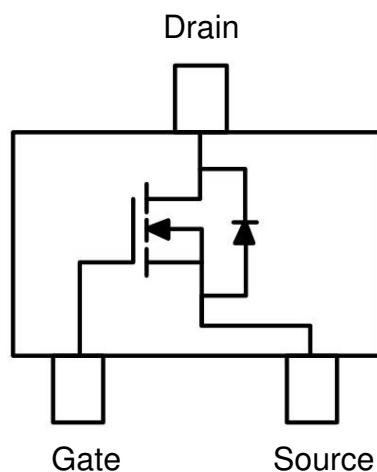
### **Applications**

- Power Management
- Lithium Ion Battery

### **Package Outline**



### **Schematic**





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### Absolute Maximum Rating at 25°C

Symbol	Parameters	Test Conditions	Min	Notes
V <sub>DS</sub>	Drain-Source Voltage	20	V	
V <sub>GS</sub>	Gate-Source Voltage	±12	V	
I <sub>D</sub>	Continuous Drain Current @T <sub>A</sub> =25°C	5.0	A	1
I <sub>DM</sub>	Pulsed Drain Current	25	A	1
P <sub>D</sub>	Total Power Dissipation @T <sub>A</sub> =25°C	1.4	W	2
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	°C	
T <sub>J</sub>	Operating Junction Temperature Range	-55 to 150	°C	

### Thermal Characteristics

Symbol	Parameters	Test Conditions	Min	Typ	Max	Units	Notes
R <sub>OJA4</sub>	Thermal Resistance Junction-Ambient (t=10s)		--	175	--	°C /W	1,4



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Electrical Characteristics  $T_A = 25^\circ\text{C}$  (unless otherwise specified)

## Static Characteristics

Symbol	Parameters	Test Conditions	Min	Typ	Max	Units	Notes
B <sub>VDSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA	20	-	-	V	
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> = 20V, V <sub>GS</sub> = 0V	-	-	1	μA	
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> = ±12V, V <sub>DS</sub> = 0V	-	-	±100	nA	

## On Characteristics

Symbol	Parameters	Test Conditions	Min	Typ	Max	Units	Notes
R <sub>DS(ON)</sub>	Drain-Source On-Resistance	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 3.0A	-	21	31	mΩ	3
		V <sub>GS</sub> = 2.5V, I <sub>D</sub> = 2.6A	-	24	37	mΩ	
		V <sub>GS</sub> = 1.8V, I <sub>D</sub> = 1.0A	-	31	47	mΩ	
V <sub>GS(th)</sub>	Gate-Source Threshold Voltage	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250μA	0.4	---	1.4	V	3

## Dynamic Characteristics

Symbol	Parameters	Test Conditions	Min	Typ	Max	Units	Notes
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 10V f = 1MHz	-	668	-	pF	
C <sub>oss</sub>	Output Capacitance		-	118	-		
C <sub>rss</sub>	Reverse Transfer Capacitance		-	86	-		

## Switching Characteristics

Symbol	Parameters	Test Conditions	Min	Typ	Max	Units	Notes
T <sub>D(ON)</sub>	Turn-On Delay Time	V <sub>DS</sub> = 5V, V <sub>GS</sub> = 4.5V, R <sub>G</sub> = 6Ω, I <sub>D</sub> = 3.6A	-	10.5	21	ns	
T <sub>R</sub>	Rise Time		-	5	10		
T <sub>D(OFF)</sub>	Turn-Off Delay Time		-	29.5	59		
T <sub>F</sub>	Fall Time		-	4.5	9		
Q <sub>G</sub>	Total Gate Charge	V <sub>DS</sub> = 10V, V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 3.6A	-	7.0	-	nC	
Q <sub>GS</sub>	Gate-Source Charge		-	1.0	-		
Q <sub>GD</sub>	Gate-Drain Charge		-	1.5	-		



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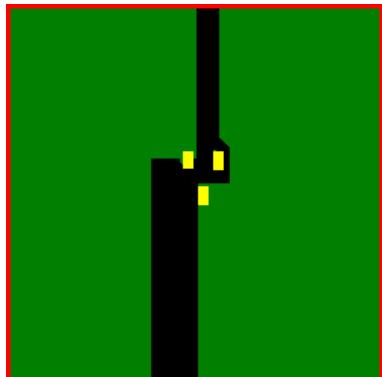
## N-Channel Enhancement MOSFET

### Drain-Source Diode Characteristics

Symbol	Parameters	Test Conditions	Min	Typ	Max	Units	Notes
V <sub>SD</sub>	Body Diode Forward Voltage	V <sub>GS</sub> = 0V, I <sub>D</sub> = 5.0	-	-	1.2	V	
I <sub>SD</sub>	Body Diode Continuous Current		-	-	5.0	A	1

Note:

1. The power dissipation is limited by 150°C junction temperature.
2. Device mounted on a glass-epoxy board



FR-4  
25.4 × 25.4 mm .  
2 Oz Copper

Actual Size

3. The data tested by pulsed , pulse width  $\leq 300\mu\text{s}$  , duty cycle  $\leq 2\%$
4. Thermal Resistance follow JESD51-3.



## Typical Characteristic Curves

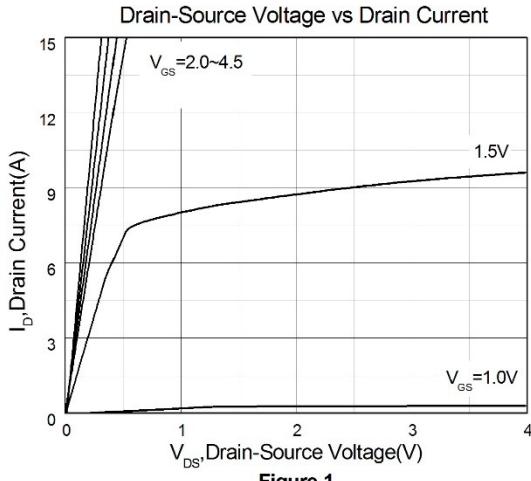


Figure 1

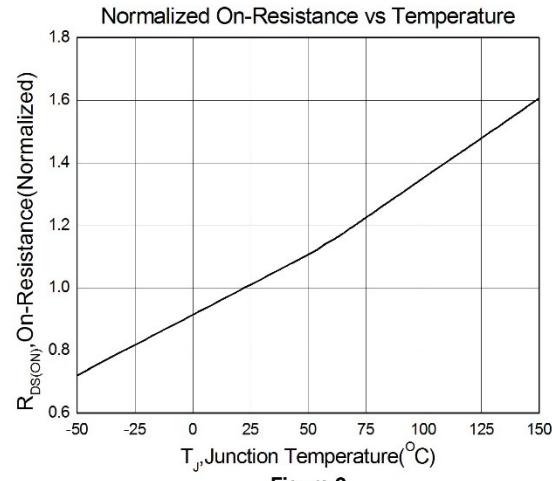


Figure 2

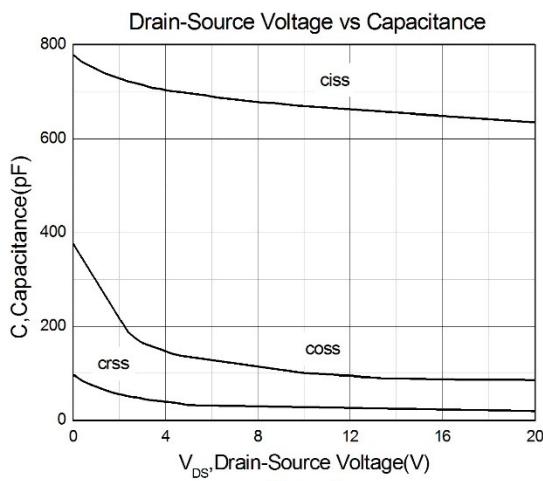


Figure 3

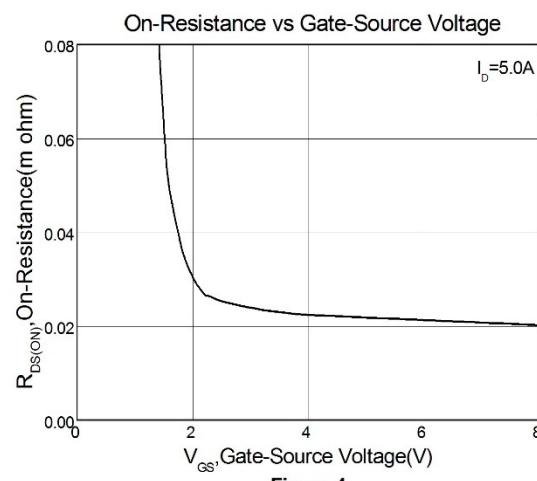


Figure 4

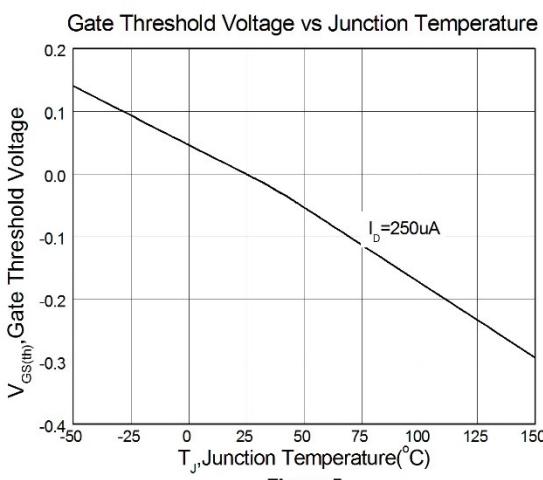


Figure 5

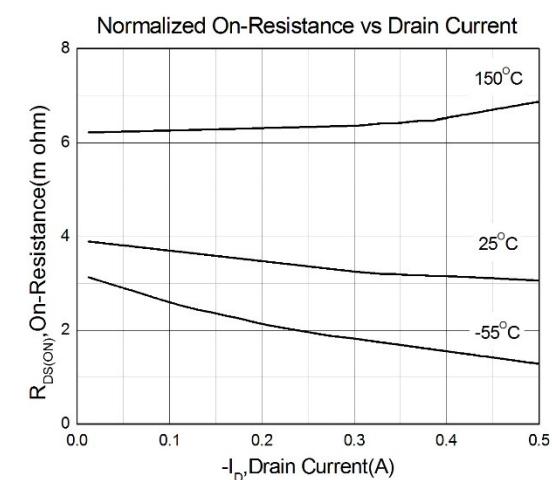


Figure 6



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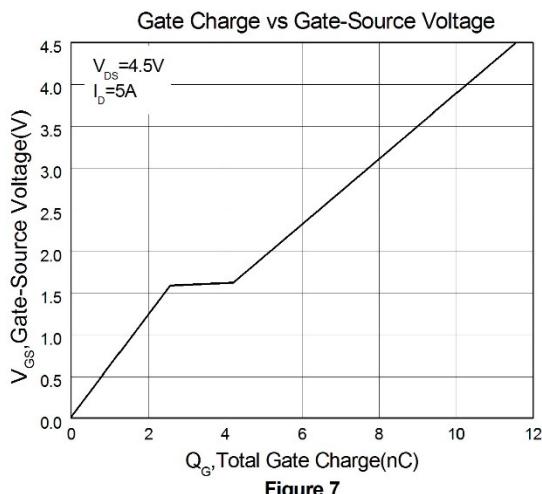


Figure 7

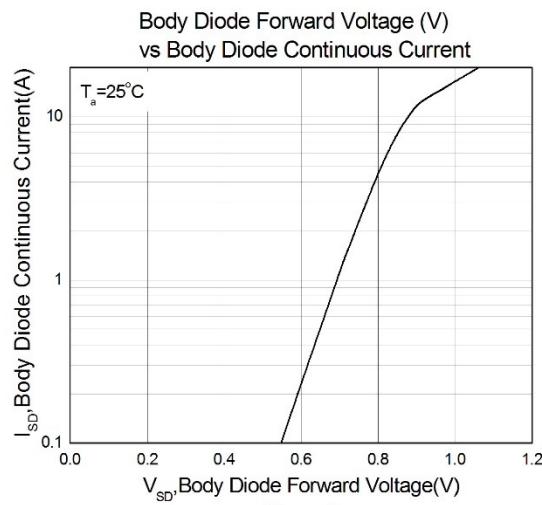


Figure 8



## Test Circuits & Waveforms

Figure 9: Gate Charge Test Circuit

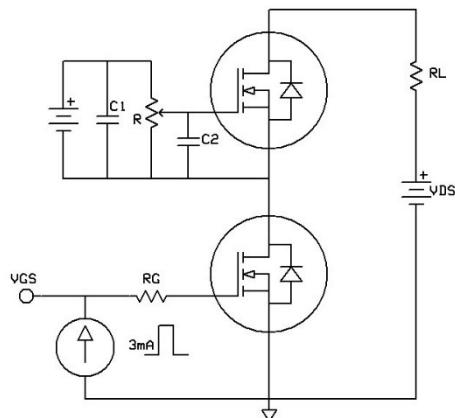


Figure 10: Gate Charge Waveform

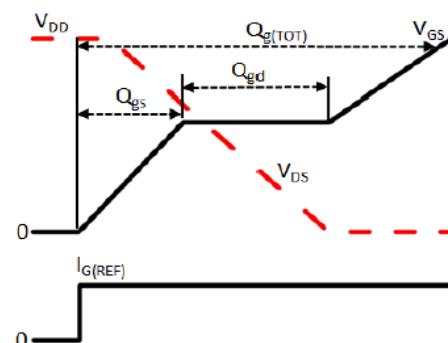


Figure 11: Switching Time Test Circuit

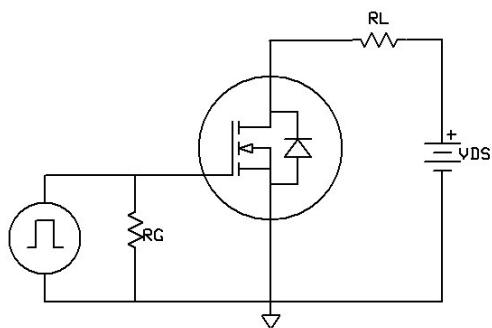
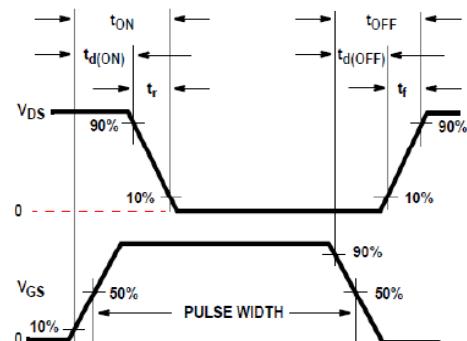


Figure 12: Switching Time Waveform

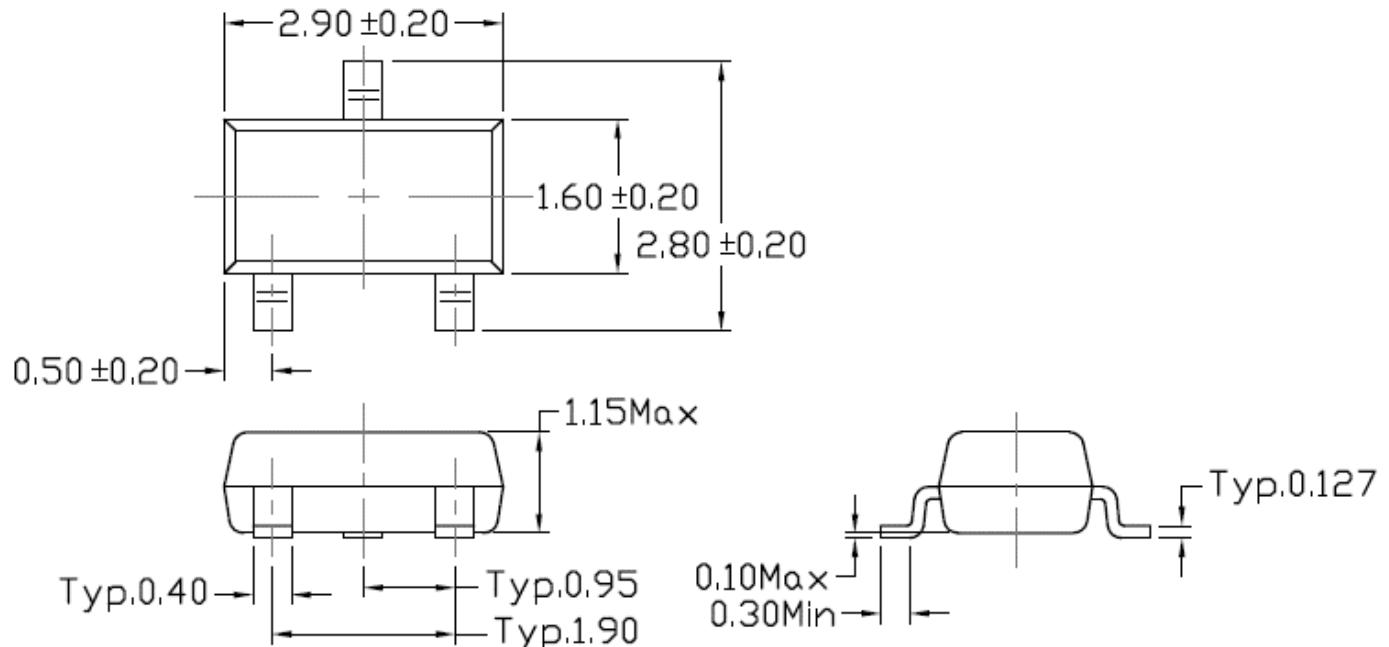




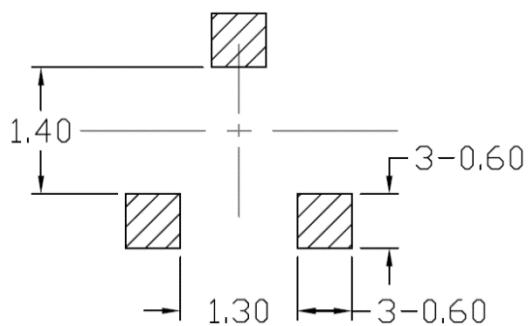
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### Package Dimension (SC-59)



### Recommended pad layout for surface mount leadform



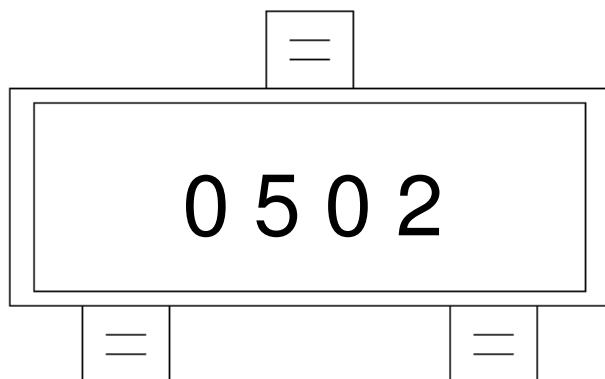


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## **Marking Information**



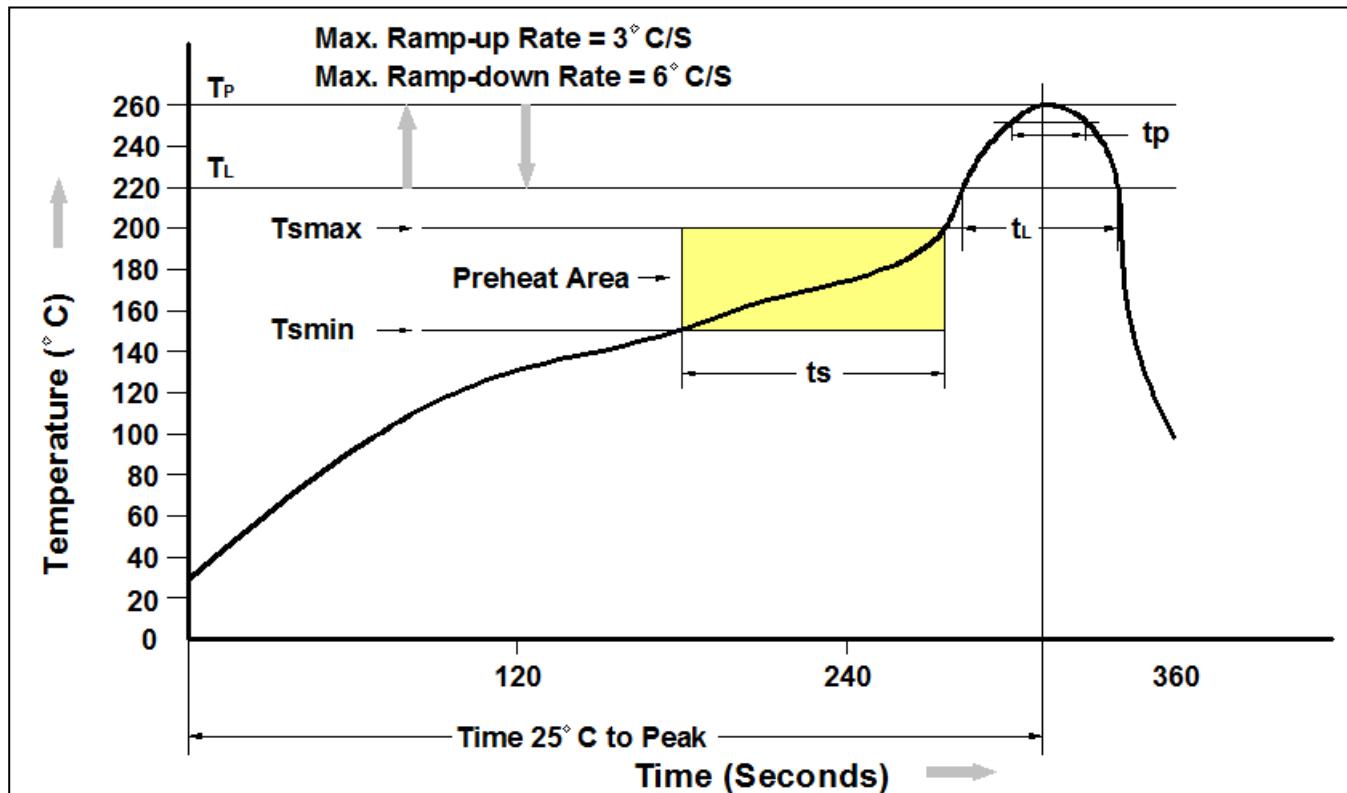
0502: Device Number

## **Ordering Information**

<b>Part Number</b>	<b>Description</b>	<b>Quantity</b>
CTL0502NS-R3	SC-59 Reel	3000 pcs



## Reflow Profile



Profile Feature	Pb-Free Assembly Profile
Temperature Min. (Tsmin)	150°C
Temperature Max. (Tsmax)	200°C
Time (ts) from (Tsmin to Tsmax)	60-120 seconds
Ramp-up Rate (tL to tp)	3°C/second max.
Liquidous Temperature (TL)	217°C
Time (tL) Maintained Above (TL)	60 – 150 seconds
Peak Body Package Temperature	260°C +0°C / -5°C
Time (tp) within 5°C of 260°C	30 seconds
Ramp-down Rate (TP to TL)	6°C/second max
Time 25°C to Peak Temperature	8 minutes max.



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